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Resonant tunneling in a colloidal CdS semiconductor quantum-dot single-electron transistor based on heteroepitaxial-spherical Au/Pt nanogap electrodes

A pioneering approach for a single quantum-dot (QD) transistor fabricated through chemisorption of colloidal CdS QD between the heteroepitaxial-spherical (HS)-Au/Pt nanogap electrodes is presented. A resonant tunneling was observed apart from the theoretical single-electron tunneling current by Coulomb blockade phenomena, which agreed with the theoretical resonant tunneling current through a discrete energy level of the QD. It suggests the coexistence of resonant tunneling current and single-electron tunneling current on a single QD device. This underscores the promise of HS-Au/Pt nanogap electrodes in realizing single-QD devices, offering a pathway toward unlocking their full potential.





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Semiconductor quantum dots (QDs) have unique discrete energy levels determined by the particle size and material. Therefore, they have potential applications as novel optical and electronic devices. Among those, colloidal group II-VI semiconductor quantum dots stand out for their facile synthesis and band gaps aligned with the visible light spectrum. However, the electrical characterization studies of an individual quantum dot necessitate the size of nanogap electrodes being equal to the size of the quantum dot, which has conventionally been evaluated using techniques such as scanning tunneling microscopy (STM) and nanogaps fabricated by electromigration. The complexity of device fabrication has restricted research in this area. Here, we present a pioneering approach for the electrical characterization of single-QD: heteroepitaxial-spherical (HS) Au/Pt nanogap electrodes. We fabricated transistors through chemisorption, an anchoring colloidal CdS QD (3.8 nm) between the HS-Au/Pt nanogap electrodes (gap separation: 4.5 nm). The resulting device functions as a quantum-dot single-electron transistor (QD-SET), showing resonant tunneling—an inherent characteristic of the QD. A steep current increase was observed at a negative voltage, apart from the theoretical single-electron tunneling current by Coulomb blockade phenomena, which agreed with the theoretical resonant tunneling current through a discrete energy level of the QD. This underscores the promise of HS-Au/ Pt nanogap electrodes in realizing single-QD devices, offering a pathway toward unlocking their full potential

Introduction

In a semiconductor quantum dot (QD), electron motion is confined to a 3D nanoscale volume. When the QD size decreases below a few tens of nanometers, the band gap energy widens compared to that of bulk crystals with decreasing size, and the energy band is discretized into different energy levels.

electrical properties of single-semiconductor QDs have been widely studied in Si QDs³⁻⁵ and groups III–V QDs⁶ and have been demonstrated through scanning tunneling microscopy^{7,8} and as a single-electron transistor (SET) operation.⁹⁻¹²

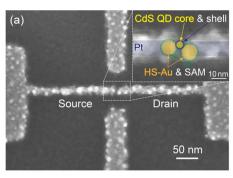
Recently, group II-VI semiconductor QDs have attracted considerable attention as materials for light-emitting devices^{13,14} and QD solar cells.¹⁵ The advantages of group II-VI semiconductor QDs are that they can be chemically synthesized as colloidal QDs, and the band gap energy has been controlled in the near-visible light region.¹⁶ Considering that the electrical properties of single QDs strongly depend on the state of discrete energy levels, colloidal QDs are promising candidates for next-generation transistor devices because of their ability to tune discrete energy levels through precise structural control.

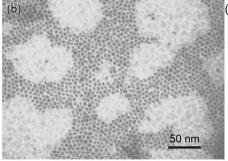
On a few nm scale of single semiconductor QD SETs based on double-barrier tunneling junctions, two current conduction phenomena of Coulomb blockade and resonant tunneling effects, which suppress and enhance electron tunneling, are observed, respectively. The single-electron tunneling current is suppressed by Coulomb blockade when the charging energy of the system by adding one electron on the Coulomb island is greater than the thermal energy. ^{17,18} On the other hand, the resonant tunneling current increases when a discrete energy level of the QD is aligned with the Fermi energy of the electrode. Previously, we reported resonant tunneling phenomena on a single π -conjugate molecule with 4.5 nm in the gap separation. ¹⁹

To observe the electrical properties of a single colloidal QD SET, it is necessary to place a single QD between nanogap electrodes with gap separation similar to its diameter. The width of electromigrated nanogap electrodes tends to be as wide as 100 nm, 12 which is much wider than the size of QDs and makes it difficult to control the precise gap separation on a few nm scale since the gap formation occurs at electromigration points.

Recently, we have established the fabrication techniques of heteroepitaxial spherical (HS-)Au/Pt nanogap electrodes.^{20,21} Robust Pt nanogap electrodes with a 10 nm gap separation and a 10 nm gap width were prepared by electron-beam lithography

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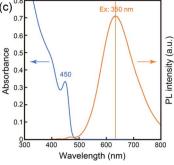


Fig. 1 (a) SEM images of the colloidal CdS semiconductor QD-SET based on heteroepitaxial spherical Au/Pt nanogap electrodes. The schematic of the QD-SET overlayed on the magnified SEM image is shown at the top right. The gap separation is 4.5 nm. The chemisorbed colloidal (blue circle) QD core (yellow circle), which behaves as a Coulomb island and contributes to resonant tunneling through its discrete energy level, was placed between heteroepitaxial spherical Au/Pt nanogap electrodes. At the gap, a pair of heteroepitaxial spherical (HS)-Au (orange circles: 8.8 and 9.6 nm) are covered by a 1,16-hexadecanedithiol and 1-dodecanethiol mixed self-assembled monolayer (green circles). (b) Scanning transmission electron microscopy (STEM) image of the synthesized CdS QDs. The core diameter of CdS QDs is 3.8 ± 0.4 nm. (c) Absorption and photoluminescence spectra of CdS QDs (1.07×10^{-4} mM, n-hexane). The excitation wavelength for the PL spectrum was 350 nm.

(EBL).20 The thermal stability of the Pt nanogap electrodes is more than 773 K.²⁰ Then, the gap separation of the Pt nanogap is decreased by the unique electroless Au-plating (ELGP) method.21,22 During ELGP, heteroepitaxial and spherical growth of Au on the Pt nanogap is obtained, and the radius of spherical Au is lower than 5 nm.21 The thermal stability of the HS-Au/Pt nanogap is higher than 573 K. We reported a single-molecule SET operation using the HS-Au/Pt nanogap electrodes.²³ As the radius is smaller than 5 nm, when a few nm scale semiconductor QDs are used, only a QD could be introduced between the HS-Au/Pt nanogap electrodes, and we could discuss the energy levels of a single QD through transistor properties.

Here, we demonstrate resonant tunneling phenomena and single-electron tunneling effects by Coulomb blockade in a colloidal CdS QD SET with a chemisorbed QD between HS-Au/Pt nanogap electrodes anchored by an alkanedithiol/alkanethiol mixed selfassembled monolayer (SAM). Steep current increases were observed in the drain current (I_d) -drain voltage (V_d) characteristics. The resonant tunneling phenomena are compared with the theoretical single-electron tunneling current based on the Coulomb blockade. The abrupt current reduction is discussed based on the shift of the discrete energy level of CdS QDs caused by the trapped charge around QDs, suppressing the resonant tunneling current.

Experimental

HS-Au/Pt nanogap electrodes were fabricated based on our previous reports.20,21 First, Pt initial nanogap electrodes were fabricated by EBL and lift-off. Nanogap patterns were prepared on a SiO₂ (50 nm)/Si substrate using EBL. Subsequently, 3 nm of Ti and 10 nm of Pt were evaporated using an electron beam evaporator and lifted off. Contact pad electrodes were prepared using photolithography liftoff. ELGP solution was prepared by dissolving a Au sheet in medical iodine tincture (I₂ and KI in ethanol), and then L(+) ascorbic acid was added as a reducing agent.21 The Pt initial nanogap electrodes with 10 nm in the gap separation and 15 nm in the gap width were immersed in the 1000 times diluted ELGP solution using deionized water for

heteroepitaxial spherical gold plating, and HS-Au/Pt nanogap electrodes were fabricated.

CdS QDs were synthesized based on previous reports.24 CdS QDs were protected using 1-dodecanethiol/dodecanoic acid/ dodecylamine. HS-Au/Pt nanogap electrodes were immersed in a 1-decanethiol solution (TCI, 1 mM, 24 h) and then in a 1,16hexadecanedithiol solution (Sigma-Aldrich, 1 mM, 24 h) to form a mixed SAM.25,26 The CdS QDs were chemisorbed between the mixed SAM-covered HS-Au/Pt nanogap electrodes using 1,16hexadecanedithiol during the immersion of the CdS QD solution (36 h).

Scanning electron microscopy (SEM) and scanning transmission electron microscopy (STEM) images were recorded using field-emission SEMs (Hitachi: SU-8000 and Regulus 8230, respectively). Electrical measurements were performed using a semiconductor parameter analyzer (Keysight, B1500) and a probe station with a helium refrigerator (Nagase, GRAIL 10-LOGOS01S) in a vacuum at 9 K. The gate voltage $V_{\rm g}$ was applied from the Si substrate as the back-gate electrode.

Results and discussion

The SEM image of the CdS QD transistor based on a CdS QD and HS-Au/Pt nanogap electrodes is shown in Fig. 1(a). The gap separation was 4.5 nm, and the pair of radii of HS-Au at the gap were 4.4 and 4.8 nm. The STEM image of the CdS QDs is shown in Fig. 1(b). The average diameter of the CdS QD core and that with a ligand shell were estimated to be 3.8 \pm 0.4 nm and 6.0 nm, respectively. The schematic of QD-SET with an overlayed magnified SEM image is shown at the top right of Fig. 1(a). The chemisorbed colloidal QD (6.0 nm) is placed between the gap (4.5 nm). The pair of HS-Au is also covered with the 1,16hexadecanedithiol and 1-dodecanethiol mixed self-assembled monolayer. As a result, a single CdS QD could be introduced between the HS-Au/Pt nanogap electrodes.

Fig. 1(c) shows the absorption and photoluminescence spectra of the CdS QDs in n-hexane. The absorption and photoluminescence peaks were at 450 and 633 nm, respectively. The

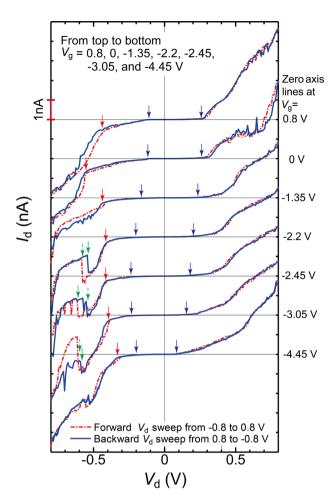


Fig. 2 Experimental I_d - V_d characteristics with V_a values of 0.8, 0, -1.35, -2.2, -2.45, -3.05, and -4.45 V under the consecutive forward (red dash-dotted lines) and backward (blue solid lines) $V_{\rm d}$ double sweeps between -0.8 and 0.8 V. Each I_d - V_d curve is offset by 2 nA. No-current V_d regions are indicated by a pair of blue arrows. The steep current increases are indicated by red arrows. The abrupt current reductions are indicated by green solid (backward V_d sweep) and dashdotted (forward V_d sweep) arrows and are observed at V_g values of -2.2, -2.45, and -3.05 V at $V_{\rm d}$ between -0.5 and -0.65 $V_{\rm d}$

bandgap energy of CdS QDs is evaluated to be 2.8 eV from the absorption peak,27 which is slightly larger than that of bulk CdS (2.4 eV). This band gap energy of CdS QDs is consistent with a previous result, 28,29 suggesting a size-dependent expansion of the band gap energy and electron confinement.

The V_g dependence of the I_d - V_d characteristics of the CdS QD transistor under consecutive forward and backward $V_{\rm d}$ sweeps between -0.8 and 0.8 V was measured at 9 K and is shown in Fig. 2. Due to a slightly large $V_{\rm d}$ sweep range between -0.8 and 0.8 V, the I_d - V_d characteristics slightly fluctuated. However, as shown in Fig. 2, the I_d - V_d characteristics under forward V_d sweep are almost equal to those under backward $V_{\rm d}$ sweep; we could discuss the I_d - V_d characteristics using the experimental results.

The no-current V_d region, indicated by a pair of blue arrows in Fig. 2, depended on $V_{\rm g}$ and increased with decreasing $V_{\rm g}$ from 0.8 to -2.2 V and then reduced with decreasing V_g from -2.2 to -4.45 V, suggesting Coulomb blockade phenomena. At positive

 $V_{\rm d}$, steep increases of $I_{\rm d}$, indicated by red arrows, are observed at $V_{\rm g}$ between 0 and -4.45 V.

Then, abrupt current reductions, indicated by green arrows, are followed at V_d between -0.50 and -0.65 V. For example, V_d of the abrupt current reduction in the forward V_d sweep (green dash-dotted arrows: $V_d = -0.58$ and -0.62 V) differs from that in the backward V_d sweep (green arrows: $V_d = -0.54$ and -0.54V) at $V_g = -2.2$ and -2.45 V, respectively. The V_d shifts at the abrupt current reduction between the forward and backward sweeps were 48 mV and 72 mV at $V_{\rm g} = -2.2$ and -2.45 V, respectively. At $V_{\rm d} = -2.45$ V, the spike current was also observed at $V_d = -0.70$ and -0.66 V in the forward V_d sweep and $V_{\rm d} = -0.57$ V in the backward $V_{\rm d}$ sweep. Consequently, the abrupt current reduction should originate from the change in the trapped charge around the CdS QD, which shifted the discrete energy level of CdS QD under the $V_{\rm d}$ sweeps.

In contrast, in the $V_d > -0.52$ V and $-0.63 < V_d < -0.73$ V (except the spike current regions), the I_d - V_d characteristics in the forward $V_{\rm d}$ sweep were equal to those in the backward $V_{\rm d}$ sweep, suggesting that the trapped charge states did not change and maintained at $V_{\rm d} > -0.52$ V at $V_{\rm g} = -2.2$ and -2.45 V, respectively.

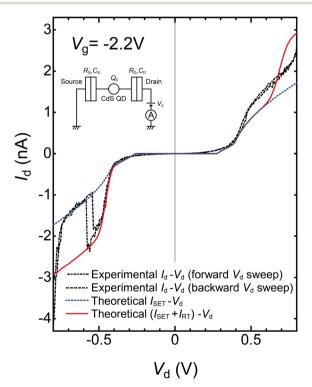


Fig. 3 Theoretical Coulomb staircase ($I_{SET}-V_{d}$) curve (blue dotted line), the sum of theoretical I_{SET} and resonant tunneling current I_{RT} (I_{SET} $+ I_{RT}$) – V_d curve (red solid line), and experimental I_d – V_d (forward (black dashed line) and backward (black dash-dotted line) V_d sweeps) curves at $V_a = -2.2$ V. The equivalent circuit of CdS-QD SET (inset). Five SET parameters are evaluated to be R_s = 280 M Ω , R_d = 50 M Ω , C_s = 0.20 aF, $C_{\rm d} = 0.30$ aF, and $Q_0 = 0.015$ e at 9 K ($V_{\rm q} = -2.2$ V) (e: unit charge). Theoretical I_{RT} is calculated based on the transmission probability on a single QD double barrier tunneling junction by using a standard deviation σ (17 meV) of the density of state (DOS) of the quantized energy level of CdS QDs and the center of DOS below the work function of the electrode μ_{QD} (0.275 eV).

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Theoretical Coulomb staircase fitting was applied in the $V_{\rm d}$ region where the Coulomb blockade breaks and I_d increases in the experimental $I_{\rm d}$ - $V_{\rm d}$ curve at $V_{\rm g}=-2.2$ V. The theoretical Coulomb staircase (I_d-V_d) curve was calculated using the orthodox theory based on Fermi's golden-rule calculation on a double-barrier tunneling junction (DBTJ) system. 30-34 Here, 5 parameters, as shown in the equivalent circuit in the inset of Fig. 3, the resistance and capacitance between the source and the Coulomb island (R_s, C_s) , those between the Coulomb island and the drain (R_d, C_d) , and offset charge of the Coulomb island Q_0 are used. Fig. 3 shows theoretical and experimental I_d - V_d curves at $V_{\rm g}=-2.2$ V. The theoretical $I_{\rm d}$ – $V_{\rm d}$ curve agrees with the experimental I_d - V_d characteristics in three V_d regions from 0.3 to 0.4, from -0.3 to -0.4, and from -0.6 to -0.7 V. The values of the 5 parameters are evaluated to be $R_s = 280 \text{ M}\Omega$, $R_d = 50 \text{ M}\Omega$, $C_s = 0.20 \text{ aF}, C_d = 0.30 \text{ aF}, \text{ and } Q_0 = 0.015 \text{ e} (V_g = -2.2 \text{ V}) \text{ (e: unit)}$ charge). The comparison of the theoretical I_d - V_d curves when one of the 5 parameters is varied by $\pm 5\%$ is shown in Fig. S1(a)–(e) (ESI).† It notes that the value changes in $\pm 5\%$ give significantly different I_d – V_d curves. As a result, the error ranges of each of the 5 parameters are within 10%.

From these parameters, the charging energy, $E_{\rm c}$ (= $e^2/2~C_{\Sigma}$, $C_{\Sigma}=C_{\rm s}+C_{\rm d}$), was estimated to be 163 meV. The experimental $|I_{\rm d}|$ gradually increased at V_d between -0.3 and -0.4 V and apart from theoretical curves. Then, the abrupt current reduction followed -0.55 V. At V_d < -0.6 V, $|I_{\rm d}|$ tends to increase again, and its value is much larger than the theoretical value.

Previously, we reported ideal single gold nanoparticle SET operations, 35 and the capacitance of colloidal metallic nanoparticles as Coulomb islands was discussed based on a concentric sphere model. 36,37 In contrast, the CdS QD is a dielectric material with a relative permittivity (ε_1) of 5.7; the capacitance of the CdS QD ($C_{\rm dot}$) can be calculated on a concentric dielectric sphere based on electromagnetism. $C_{\rm dot}$ is given by:

$$C_{\text{dot}} = 8\pi\varepsilon_0 r \left(\frac{\varepsilon_1 \varepsilon_2 (r+d)}{2\varepsilon_1 \varepsilon_2 r + 2\varepsilon_1 d + \varepsilon_2 (r+d)} \right) \tag{1}$$

where ε_0 is the electric constant, ε_2 is the relative permittivity of protecting groups (2.6),³⁸ r is the radius of the CdS core, and d is the shell thickness of the protecting group (1.4 nm).

If we assume $C_{\rm s}$ and $C_{\rm d}$ of 0.20 and 0.30 aF as $C_{\rm dot}$, the core diameter (2r) of the CdS QD is evaluated to be 2.9 and 4.6 nm from eqn (1), respectively. As the core of the CdS QD was chemisorbed through 1,16-hexadecanedithiol and placed near S/D electrodes, $C_{\rm s}$ and $C_{\rm d}$ should be slightly larger than $C_{\rm dot}$. Consequently, the evaluated $C_{\rm s}$ and $C_{\rm d}$ values of 0.20 and 0.30 aF agree with an average CdS QD core diameter of 3.8 \pm 0.4 nm (Fig. 1(b)). This agreement suggests that the CdS QD behaves as a Coulomb island in the SET, and the current rise regions in $I_{\rm d}$ – $V_{\rm d}$ characteristics are attributed to Coulomb blockade phenomena on a single CdS QD.

The experimental V_d – V_g 2D dI_d / dV_d plot is shown in Fig. 4. Herein, dI_d / dV_d was calculated numerically from the experimental I_d – V_d characteristics. As mentioned above, dI_d / dV_d – V_d characteristics in the 2D plot also fluctuated owing to a slightly large V_d sweep range. Although the dI_d / dV_d plot is noisy, Coulomb

diamond is partially outlined as a pair of lines.³⁹ $V_{\rm g}$ dependence of the pair of inflection points at breaking Coulomb blockade was observed between $-1.35 > V_{\rm g} > -3.05$ V in Fig. 4.

As shown in Fig. 3, the experimental initial current increases in the $V_{\rm d}$ region of $-0.4 < V_{\rm d} < 0.4$ V, where the Coulomb blockade break agrees with the theoretical $I_{\rm d}$ – $V_{\rm d}$ curve. In the negative $V_{\rm d}$ region of $-0.55 < V_{\rm d} < -0.4$, the experimental $I_{\rm d}$ – $V_{\rm d}$ curve was apart from the theoretical Coulomb staircase, and a steep increase in $I_{\rm d}$ was observed as shown in Fig. 3. This steep increase in $I_{\rm d}$ could be explained as the resonant tunneling through a discrete energy level of the CdS QD as follows.

Resonant tunneling current in a single QD double barrier tunneling junction is estimated from the transmission probability. Here, we assume that the transmission probability is proportional to the density of states (DOS) of the quantized energy level in the quantum dot (QD) within the voltage window between the source and drain electrodes. In addition, the density of states of the Au electrodes below and above the work function was assumed to be constant. The DOS of the quantized energy level in the QD is also considered a Gaussian distribution with a standard deviation σ .

In the double-barrier tunneling junction, $C_{\rm s}$ and $C_{\rm d}$ were estimated using the theoretical Coulomb staircase. When $V_{\rm d}$ is applied between the source and drain, the voltage shift ($\Delta V_{\rm QD}$) of the DOS is expressed as

$$\Delta V_{\rm QD} = \frac{C_{\rm d}}{C_{\rm s} + C_{\rm d}} V_{\rm d} \tag{2}$$

Then, the resonant tunnel current I_{RT} is expressed as

$$I_{\rm RT} = A \int_0^{V_{\rm d}} \frac{1}{\sqrt{2\pi\sigma}} \exp\left\{-\frac{\left(eV - \mu_{\rm QD} - e\Delta V_{\rm QD}\right)^2}{2\sigma^2}\right\} dV \quad (3)$$

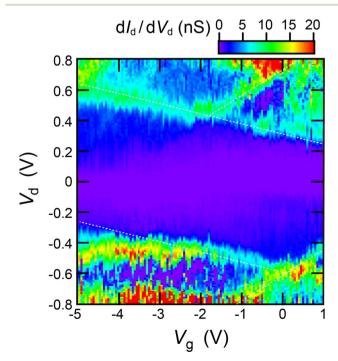


Fig. 4 Experimental V_d – V_g 2D dI_d / dV_d plot. The Coulomb diamond is outlined with white dotted lines.

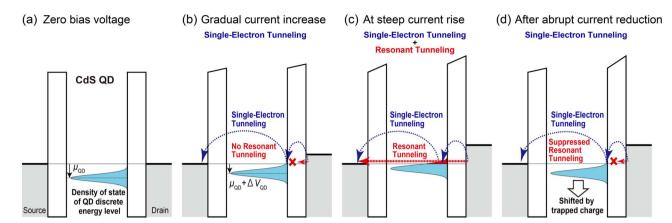


Fig. 5 Band diagrams of a single CdS QD SET (a) at zero bias voltage, (b) gradual current increase, (c) steep current increase, and (d) after the abrupt current reduction by trapped charge around the CdS QD. The light blue and partially red Gaussian distribution represents the density of state at the CdS QD discrete energy level. Resonant tunneling and single-electron tunneling due to Coulomb blockade are shown as red dotted-line arrows and a pair of blue dotted-semicircle arrows, respectively.

where *A* is a constant and $\mu_{\rm QD}$ is the center of DOS below the work function of the drain electrode at $V_{\rm d}=0$.

The theoretical $I_{\rm RT}$ – $V_{\rm d}$ curve is shown in Fig. S2,† where $\mu_{\rm QD}$ = 0.275 eV, σ = 17 meV, and A = 1.2 × 10⁻⁹ A. The sum of the theoretical ($I_{\rm SET}$ + $I_{\rm RT}$) – $V_{\rm d}$ curve is shown in Fig. 3 (red solid line). It is noted that the theoretical ($I_{\rm SET}$ + $I_{\rm RT}$) – $V_{\rm d}$ curve agrees with the experimental results where –0.5 V < $V_{\rm d}$ < –0.3 V. Consequently, the steep current increase in the $I_{\rm d}$ – $V_{\rm d}$ characteristics originated from the resonant tunneling through a discrete energy level of the CdS QD.

The band diagrams of the CdS QD SET at the zero-bias voltage, the gradual current increase ($I_{\rm SET}$), the steep current increase ($I_{\rm SET}+I_{\rm RT}$), and the abrupt current reduction are shown in Fig. 5(a)–(d), respectively. The DOS of the quantized energy level of the CdS QD is expressed using a Gaussian distribution with a standard deviation σ , which exists below $\mu_{\rm QD}$ from the work function of the source and drain electrodes, as shown in Fig. 5(a). When negative $V_{\rm d}$ is applied, DOS upshifts $\Delta V_{\rm QD}$, the Coulomb blockade condition breaks, and $I_{\rm SET}$ starts to flow, as shown in Fig. 5(b).

At the steep current rise region, as demonstrated in the theoretical ($I_{\rm SET}+I_{\rm RT}$)– $V_{\rm d}$ curve in Fig. 3, the resonant tunneling current $I_{\rm RT}$ flowed at $V_{\rm d}<-0.4$ as indicated by the red dotted line in Fig. 5(c), where the DOS of the discrete energy level of the CdS QD overlaps the voltage window between the source and drain electrodes (red region of DOS in Fig. 5(c)). As shown in the theoretical ($I_{\rm SET}+I_{\rm RT}$)– $V_{\rm d}$ curve in Fig. 3, $I_{\rm RT}$ flowed at the steep current increase together with the single-electron tunneling current $I_{\rm SET}$ (two blue dotted-semicircle arrows in Fig. 5(c)).

The change in the trapped charge should shift the discrete energy level of the CdS QD as shown in Fig. 5(d), and an abrupt current reduction was observed. Due to the trapped charge, the DOS of the discrete energy level shifted lower, and $I_{\rm RT}$ was suppressed, as shown in Fig. 5(d). After the abrupt current reduction, $I_{\rm d}$ became equal to the theoretical $I_{\rm SET}$ – $V_{\rm d}$ curve, as shown in Fig. 3. Consequently, the abrupt current reduction on this CdS QD SET is attributed to the trapped

charge around the CdS QD, which suppressed the resonant tunneling current.

The HS-Au/Pt nanogap-based CdS QD-SET is significant for the observation of the resonant tunneling current attributed to the existence of the discrete energy level and single-electron tunneling current based on Coulomb blockade phenomena.

Conclusions

In conclusion, resonant tunneling and single-electron tunneling effects based on the Coulomb blockade effect were observed in the I_d - V_d characteristics and V_d - V_g 2D dI_d/dV_d plot in a CdS (3.8 nm) QD-SET based on HS-Au/Pt nanogap electrodes with a gap separation of 4.5 nm. Experimental I_d - V_d characteristics without the resonant tunneling effect agreed well with the theoretical curve based on the orthodox theory, which suggests that the electrical properties of this device originate from a CdS QD-SET. In the steep current rise region, the resonant tunneling current was observed and agreed well with the theoretical calculation based on the transmission probability at a single QD double barrier tunneling junction, where the single-electron tunneling current and the resonant tunneling current coexisted. The abrupt current reductions have been attributed to suppressing the resonant tunneling current caused by the trapped charge, which shifted the discrete energy level of the CdS QD. The HS-Au/Pt nanogap electrodes are a significant platform for observing electrical conduction in a single semiconductor QD, which opens a pathway to demonstrate their potential.

Author contributions

Conceptualization: Y. M. and T. T.; methodology: Y. M. and G. O.; synthesis of CdS QDs: M. S. and T. T.; fabrication and measurement of the QD-SET: G. O. and T. N.; theoretical calculation: G. O. and Y. M.; analysis: G. O. and Y. M., writing – original draft: G. O.; writing – review and editing: Y. M.; funding acquisition: Y. M.

Conflicts of interest

There are no conflicts to declare.

Acknowledgements

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